

**Notice of References Cited**

Application/Control No.

10/562,211

Applicant(s)/Patent Under  
Reexamination  
BIJVOET ET AL.

Examiner

Brooke Purinton

Art Unit

2881

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,795,518 A	01-1989	Meinel et al.	156/285
*	B	US-6,281,654 B1	08-2001	Lee, Martin E.	318/649
*	C	US-6,480,260 B1	11-2002	Donders et al.	355/53
*	D	US-2002/0179850 A1	12-2002	Novak et al.	250/491.1
*	E	US-6,556,281 B1	04-2003	Govil et al.	355/72
*	F	US-2003/0197841 A1	10-2003	Araki et al.	355/50
*	G	US-6,654,095 B1	11-2003	Nishi, Kenji	355/30
*	H	US-6,683,433 B2	01-2004	Lee, Martin E.	318/649
*	I	US-2005/0068512 A1	03-2005	Shiraishi, Naomasa	355/067
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 11040657 A	02-1999	Japan	SATO, TAKESHI	H01L 21/68
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.